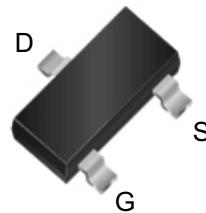


## WNM4009

**Single N-Channel, 110V, 1.7A, Power MOSFET**

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

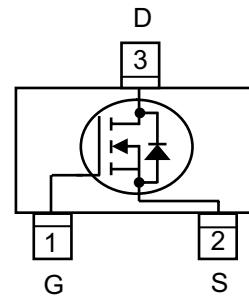
<b>V<sub>DS</sub> (V)</b>	<b>Typical R<sub>DS(on)</sub> (Ω)</b>
110	0.235@ V <sub>GS</sub> =10V
	0.260@ V <sub>GS</sub> =4.5V



SOT-23

## Descriptions

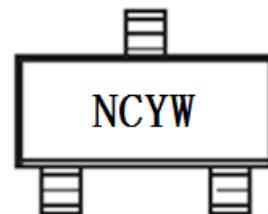
The WNM4009 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM4009 is Pb-free and Halogen-free.



Pin configuration (Top view)

## Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Small package SOT-23



NC = Device Code

Y = Year

W = Week

Marking

## Applications

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

## Order information

Device	Package	Shipping
WNM4009-3/TR	SOT-23	3000/Reel&Tape

### Absolute Maximum ratings

Parameter	Symbol	1S	10 S	Steady State	Unit	
Drain-Source Voltage	V <sub>DS</sub>		110		V	
Gate-Source Voltage	V <sub>GS</sub>		±20			
Continuous Drain Current <sup>a d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	2.03	1.70	1.45	A
	T <sub>A</sub> =70°C		1.62	1.36	1.16	
Maximum Power Dissipation <sup>a d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	2.27	1.60	1.15	W
	T <sub>A</sub> =70°C		1.45	1.02	0.74	
Continuous Drain Current <sup>b d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	1.88	1.50	1.34	A
	T <sub>A</sub> =70°C		1.5	1.20	1.07	
Maximum Power Dissipation <sup>b d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	1.95	1.25	1.00	W
	T <sub>A</sub> =70°C		1.25	0.80	0.64	
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>		7		A	
Operating Junction Temperature	T <sub>J</sub>		-55 to 150		°C	
Lead Temperature	T <sub>L</sub>		260		°C	
Storage Temperature Range	T <sub>stg</sub>		-55 to 150		°C	

### Thermal resistance ratings

Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 1 s	R <sub>θJA</sub>	40	55
	t ≤ 10 s		60	78
	Steady State		88	108
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t ≤ 1 s	R <sub>θJA</sub>	50	64
	t ≤ 10 s		85	100
	Steady State		105	125
Junction-to-Case Thermal Resistance	Steady State	R <sub>θJC</sub>	60	75

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

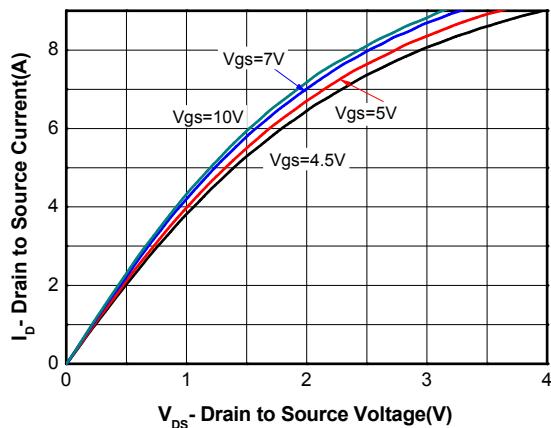
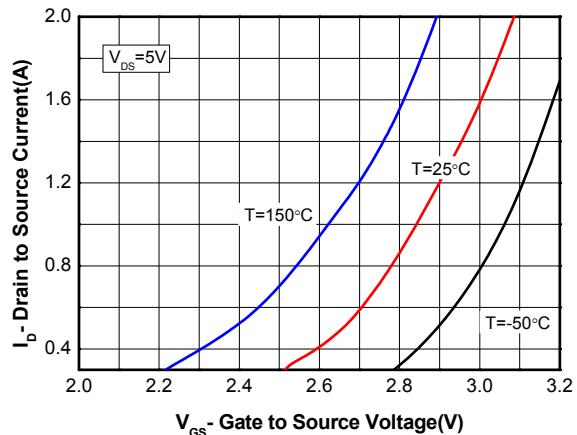
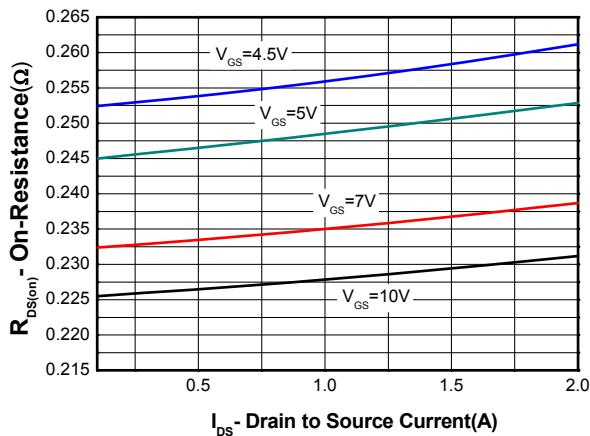
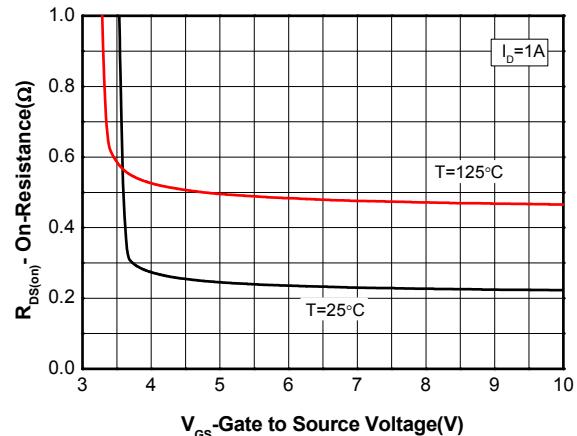
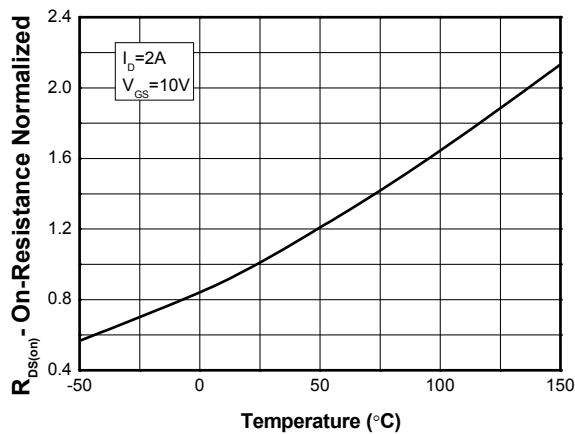
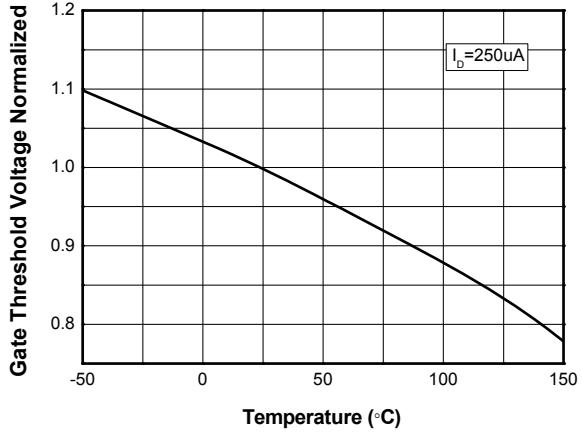
b Surface mounted on FR-4 board using minimum pad size, 1oz copper

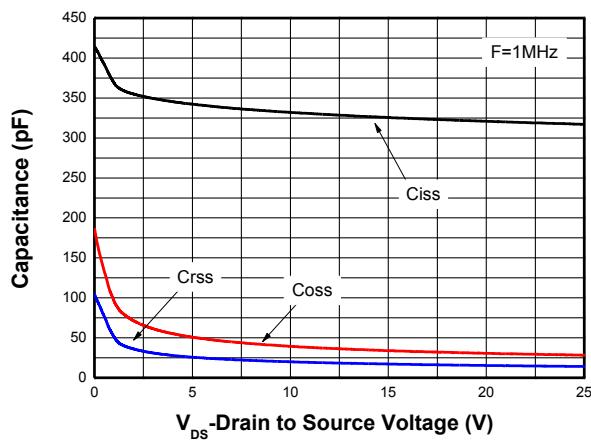
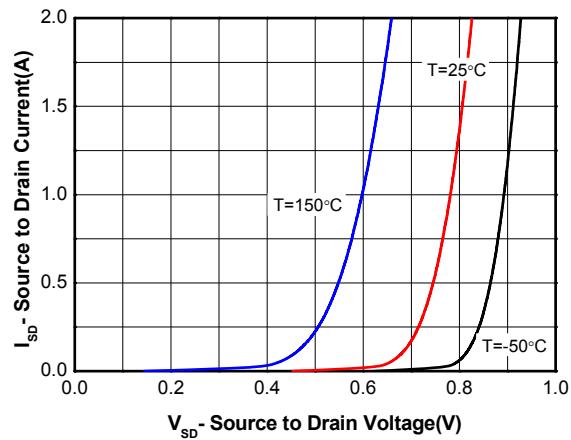
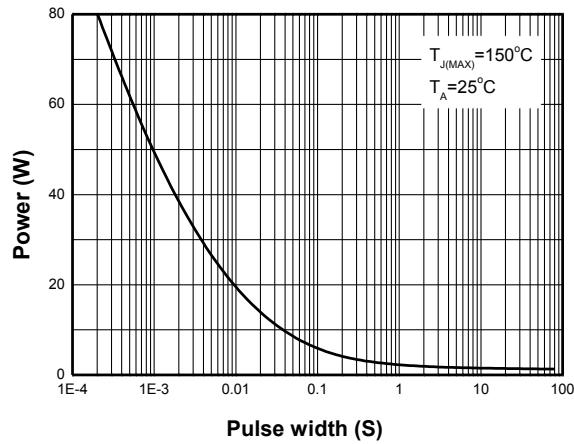
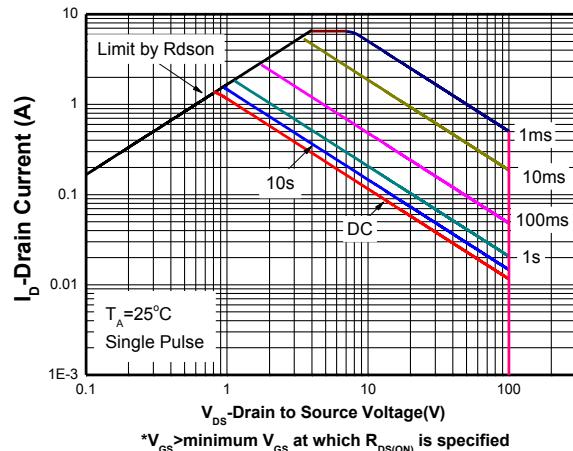
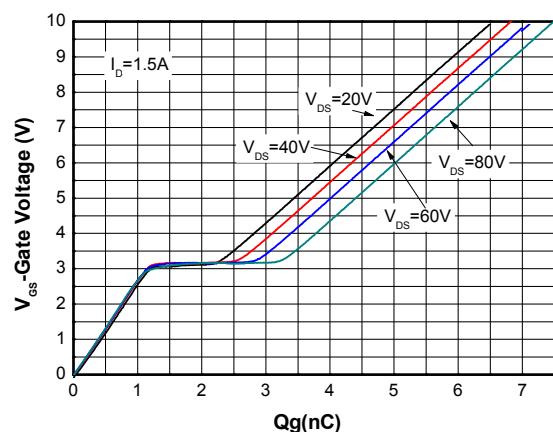
c Pulse width<380μs, Duty Cycle<2%

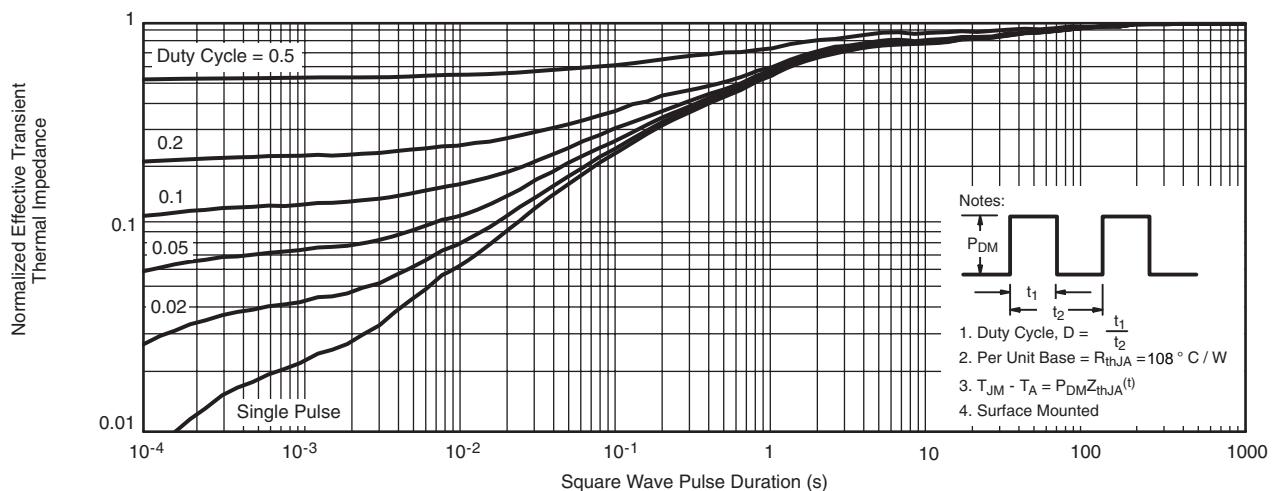
d Maximum junction temperature T<sub>J</sub>=150°C.

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

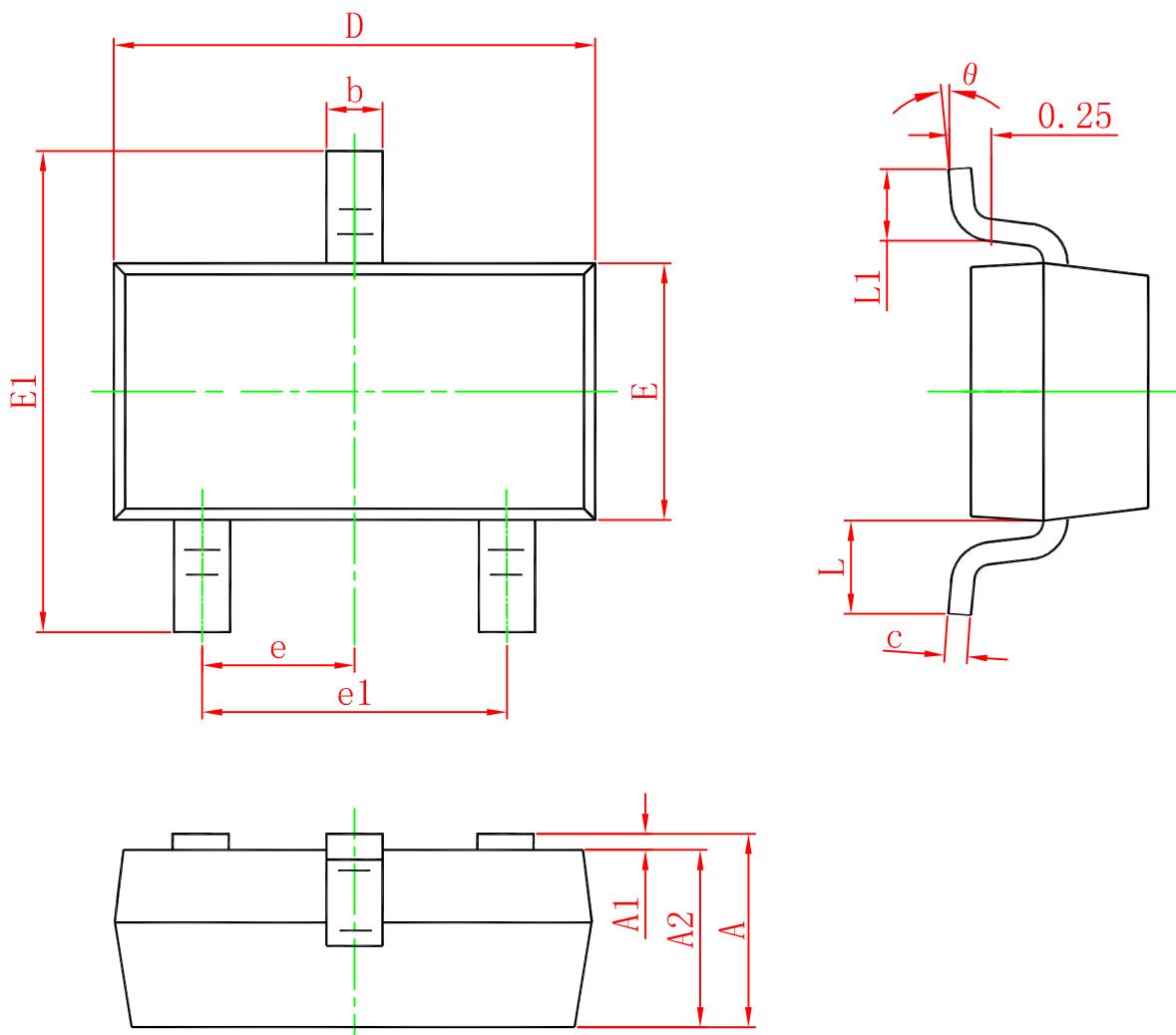
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA	110			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 90V, V <sub>GS</sub> = 0V			1	uA
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20V			±100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250uA	1	1.9	2.5	V
Drain-to-source On-resistance <sup>b, c</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 1.5A		235	310	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 1.3A		260	350	
Forward Trans conductance	g <sub>fs</sub>	V <sub>DS</sub> = 10V, I <sub>D</sub> = 3A		1.1		S
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V		317		pF
Output Capacitance	C <sub>OSS</sub>			28		
Reverse Transfer Capacitance	C <sub>RSS</sub>			14		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 80 V, I <sub>D</sub> = 1.5 A		7.5		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			0.7		
Gate-to-Source Charge	Q <sub>GS</sub>			1.1		
Gate-to-Drain Charge	Q <sub>GD</sub>			2.1		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	td(ON)	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 50 V, R <sub>L</sub> =50 Ω, R <sub>G</sub> =3.3 Ω		11.8		ns
Rise Time	tr			13.2		
Turn-Off Delay Time	td(OFF)			32.8		
Fall Time	tf			4.8		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1A		0.8	1.2	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-Source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Junction temperature**

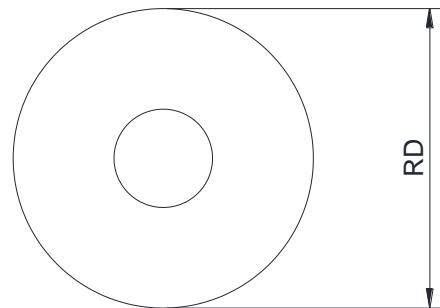
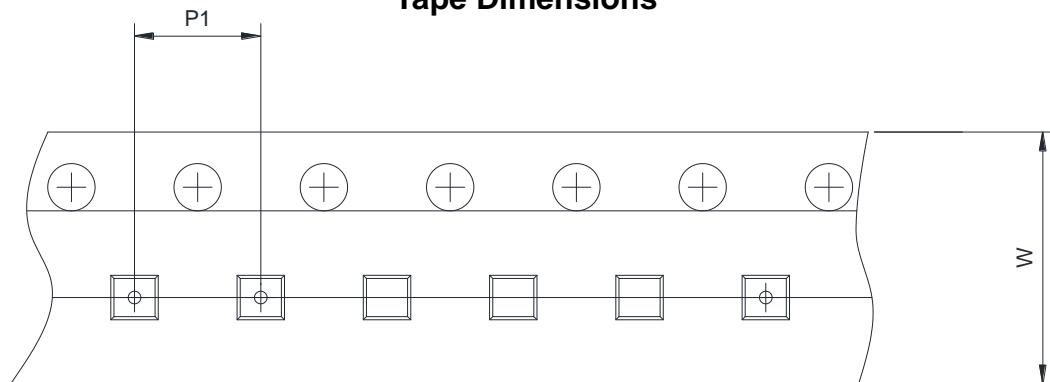
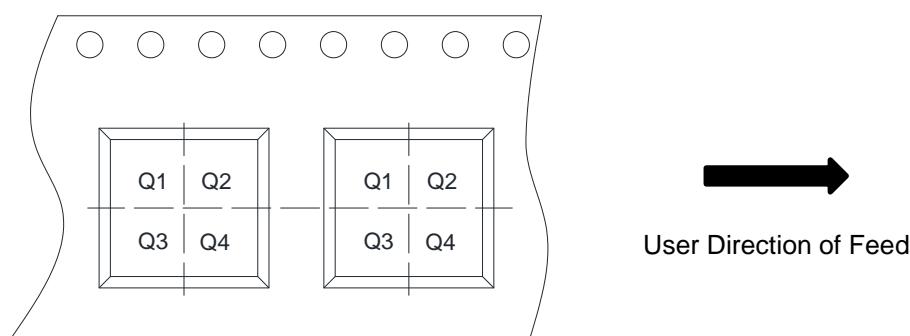

**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate charge Characteristics**



**Transient thermal response (Junction-to-Ambient)**

**Package outline dimensions**
**SOT-23**


Symbol	Dimensions In Millimeters	
	Min.	Max.
A	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
E1	2.250	2.550
e	0.950 (Typ.)	
e1	1.800	2.000
L	0.550 (Typ.)	
L1	0.300	0.500
θ	0°	8°

**APE AND REEL INFORMATION**
**Reel Dimensions**

**Tape Dimensions**

**Quadrant Assignments For PIN1 Orientation In Tape**


<b>RD</b>	Reel Dimension	<input checked="" type="checkbox"/> 7inch	<input type="checkbox"/> 13inch		
<b>W</b>	Overall width of the carrier tape	<input checked="" type="checkbox"/> 8mm	<input type="checkbox"/> 12mm <input type="checkbox"/> 16mm		
<b>P1</b>	Pitch between successive cavity centers	<input type="checkbox"/> 2mm	<input checked="" type="checkbox"/> 4mm	<input type="checkbox"/> 8mm	
<b>Pin1</b>	Pin1 Quadrant	<input type="checkbox"/> Q1	<input type="checkbox"/> Q2	<input checked="" type="checkbox"/> Q3	<input type="checkbox"/> Q4